


<b>Search Notes</b>  	<b>Application/Control No.</b>  10509168	<b>Applicant(s)/Patent Under Reexamination</b>  DE WILDE ET AL.
	<b>Examiner</b>  Truc T Nguyen	<b>Art Unit</b>  2833

SEARCHED			
Class	Subclass	Date	Examiner
439	39-40, 308-309	3/30/08	tn
248	316.4	3/30/08	tn

SEARCH NOTES		
Search Notes	Date	Examiner
same as search	3/30/08	tn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
see east printed		3/30/08	tn